Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/674,769	EHRICH ET AL.	
Examiner	Art Unit	
Thu V. Huynh	2178	

SEARCHED				
Class	Subclass	Date	Examiner	
715	513, 523	11/18/2005	TVH	
715	501.1	11/18/2005	TVH	
715	781	11/18/2005	TVH	
715	760, 738	11/18/2005	TVH	
709	217-219	11/18/2005	TVH	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB) See Search History Printout	11/18/2005	TVH
IEEE and Proquest	11/18/2005	т∨н
Inventor Name Search	11/16/2005	т∨н
§101 and §112 Panel Consulted: Tod Swann, Pat Salce and William Grant.	11/16/2005	TVH
§ 112 Consulted: Primary William Bashore	11/18/2005	TVH